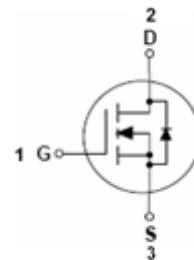


### Features

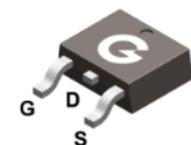
- Low power loss by high speed switching and low on-resistance
- Excellent thermal behavior
- HBM: JESD22-A114-B: 1A
- Product validation acc. JEDEC Standard

HF



### APPLICATIONS

- PFC power supply stages
- Lighting applications
- Adapter



### Mechanical Data

- Case: TO-252
- Molding Compound: UL Flammability Classification Rating 94V-0
- Terminals: Matte tin-plated leads; solderability-per MIL-STD-202, Method 208

TO-252

### Ordering Information

Part Number	Package	Shipping Quantity	Marking Code
SJ60R380D	TO-252	80 pcs / Tube & 2500 pcs / Tape & Reel	SJ60R380D

### Maximum Ratings (@ $T_c = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Value	Unit
Drain-to-Source Voltage	$V_{DSS}$	600	V
Gate-to-Source Voltage	$V_{GSS}$	$\pm 30$	V
Continuous Drain Current ( $T_c = 25^\circ\text{C}$ )	$I_D$	11	A
Continuous Drain Current ( $T_c = 100^\circ\text{C}$ )		7	A
Pulsed Drain Current ( $t_p = 10\mu\text{s}$ , $T_c = 25^\circ\text{C}$ )	$I_{DM}$	44	A
Single Pulse Avalanche Energy <sup>3</sup>	$E_{AS}$	100	mJ
Power Dissipation ( $T_c = 25^\circ\text{C}$ )	$P_D$	90	W
Operating Junction Temperature Range	$T_J$	-55 ~ +150	$^\circ\text{C}$
Storage Temperature Range	$T_{STG}$	-55 ~ +150	$^\circ\text{C}$

### Thermal Characteristics

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	-	-	1.4	$^\circ\text{C}/\text{W}$
Thermal Resistance Junction-to-Air <sup>1</sup>	$R_{\theta JA}$	-	-	62	$^\circ\text{C}/\text{W}$

**Electrical Characteristics** (@  $T_A = 25^\circ\text{C}$  unless otherwise specified)

Symbol	Parameter	Test Condition	Min.	Typ.	Max.	Unit
<b>Static Characteristics</b>						
$V_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{V}$ , $I_D = 250\mu\text{A}$	600	-	-	V
$I_{DS(0)}$	Zero Gate Voltage Drain Current	$V_{DS} = 600\text{V}$ , $V_{GS} = 0\text{V}$	-	-	1	$\mu\text{A}$
$I_{GSS}$	Gate-Body Leakage Current	$V_{GS} = \pm 30\text{V}$ , $V_{DS} = 0\text{V}$	-	-	$\pm 100$	nA
<b>On Characteristics</b>						
$R_{DS(ON)}$	Drain-Source On-resistance <sup>*2</sup>	$V_{GS} = 10\text{V}$ , $I_D = 5\text{A}$	-	0.35	0.38	$\Omega$
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_D = 250\mu\text{A}$	2	3	4	V
$R_G$	Gate Resistance	$V_{GS} = 0\text{V}$ , $f = 1\text{MHz}$	-	4	-	$\Omega$
<b>Dynamic Characteristics</b>						
$C_{iss}$	Input Capacitance	$V_{GS} = 0\text{V}$	-	633	-	pF
$C_{oss}$	Output Capacitance	$V_{DS} = 40\text{V}$	-	49	-	
$C_{rss}$	Reverse Transfer Capacitance	$f = 250\text{kHz}$	-	2	-	
<b>Switching Characteristics</b>						
$t_{d(ON)}$	Turn-on Delay Time <sup>*4</sup>	$V_{DD} = 480\text{V}$ $V_{GS} = 10\text{V}$ $I_D = 5\text{A}$	-	57	-	ns
$t_r$	Turn-on Rise Time <sup>*4</sup>		-	30	-	
$t_{d(OFF)}$	Turn-Off Delay Time <sup>*4</sup>		-	73	-	
$t_f$	Turn-Off Fall Time <sup>*4</sup>		-	15	-	
$Q_G$	Total Gate-Charge	$V_{DD} = 480\text{V}$ $V_{GS} = 10\text{V}$ $I_D = 10\text{A}$	-	24	-	nC
$Q_{GS}$	Gate to Source Charge		-	3.3	-	
$Q_{GD}$	Gate to Drain (Miller) Charge		-	14	-	
<b>Source-Drain Diode Characteristics</b>						
$V_{SD}$	Diode Forward Voltage <sup>*2</sup>	$I_{SD} = 5\text{A}$ , $V_{GS} = 0\text{V}$	-	0.8	1.2	V
$t_{rr}$	Reverse Recovery Time	$I_F = 10\text{A}$ , $V_R = 400\text{V}$	-	250	-	ns
$Q_{rr}$	Reverse Recovery Charge	$dI/dt = 100\text{A}/\mu\text{s}$	-	2.45	-	$\mu\text{C}$

**Notes:**

1. The data tested by surface mounted on a minimum recommended FR-4 board
2. The data tested by pulsed, pulse width  $\leq 300\mu\text{s}$ , duty cycle  $\leq 2\%$
3. The  $E_{AS}$  data shows Max. rating. The test condition is  $V_{DD} = 100\text{V}$ ,  $V_{GS} = 15\text{V}$ ,  $L = 50\text{mH}$
4. Guaranteed by design, not subject to production

### Ratings and Characteristics Curves (@ $T_A = 25^\circ\text{C}$ unless otherwise specified)

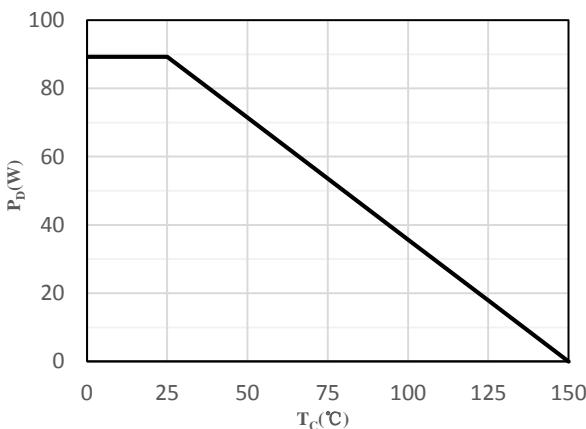


Fig 1 Power Dissipation

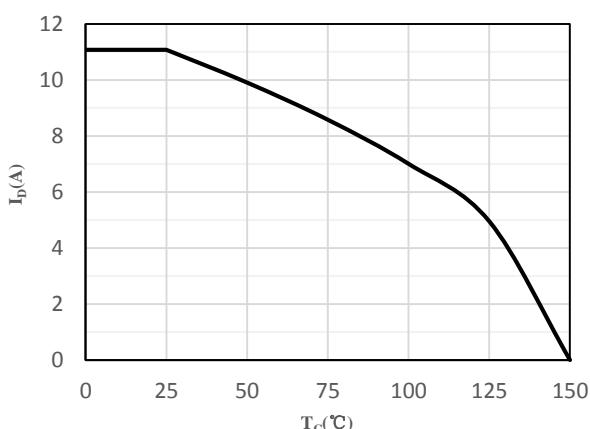


Fig 2 Drain Current

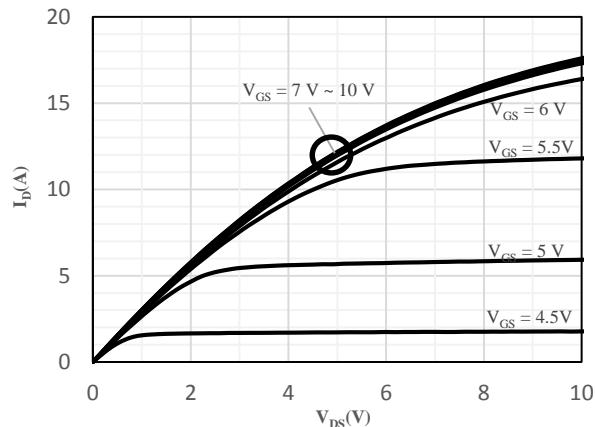


Fig 3 Typical Output Characteristics

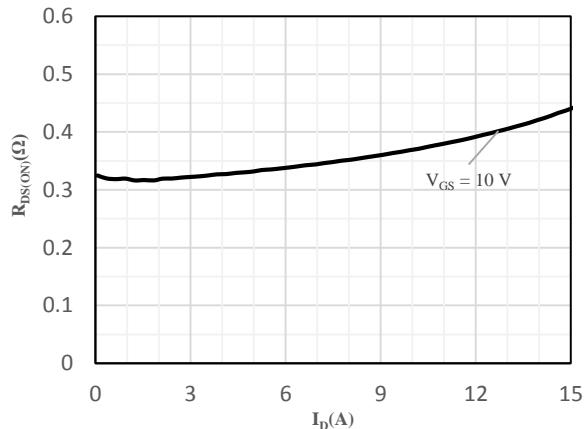


Fig 4 On-Resistance vs. Drain Current

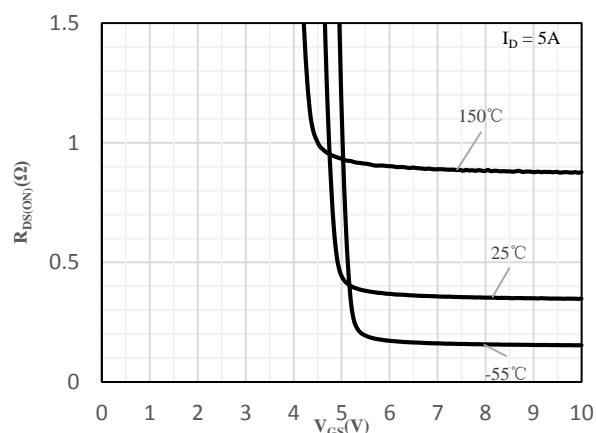


Fig 5 On-Resistance vs. Gate-Source Voltage

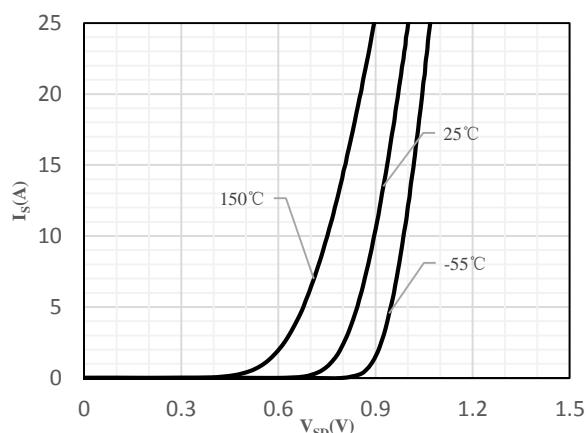
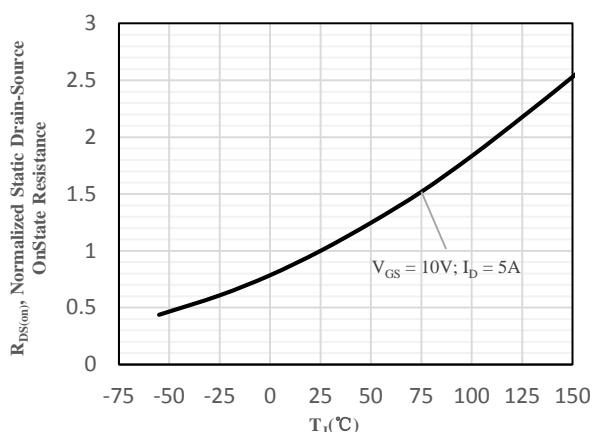
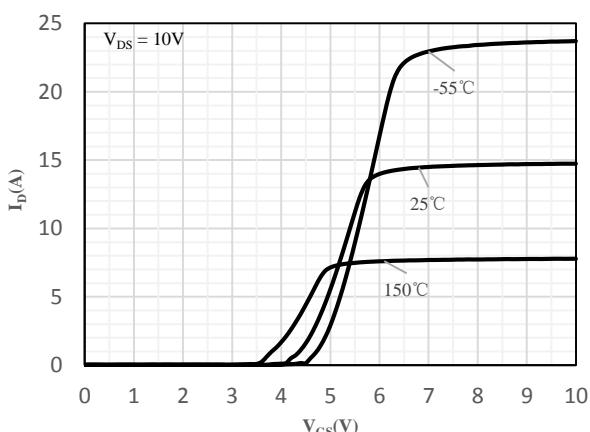


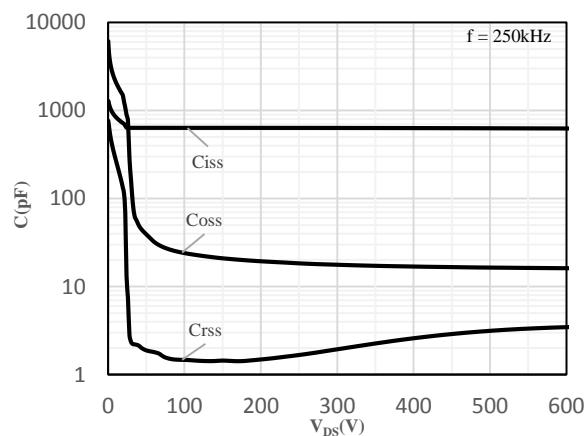
Fig 6 Body-Diode Characteristics



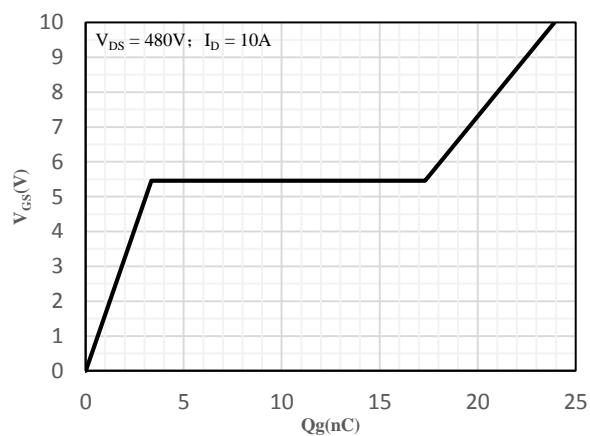
**Fig 7 Normalized On-Resistance vs. Junction Temperature**



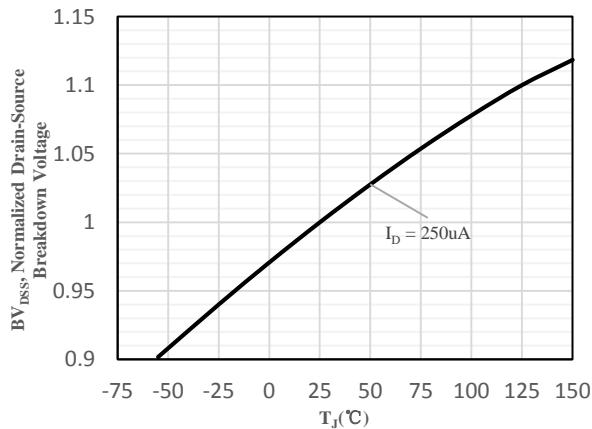
**Fig 8 Transfer Characteristics**



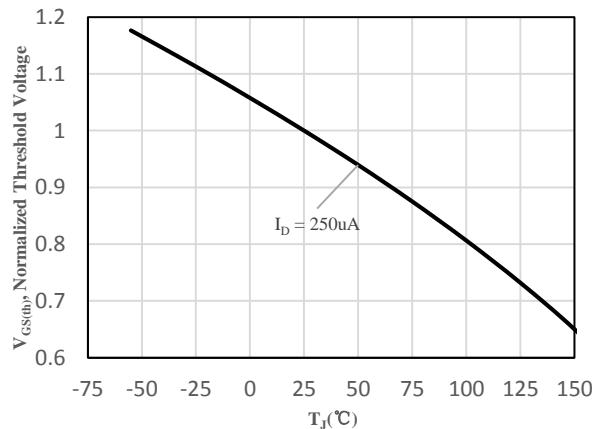
**Fig 9 Capacitance Characteristics**



**Fig 10 Gate-Charge Characteristics**



**Fig 11 Normalized Breakdown Voltage vs. Junction Temperature**



**Fig 12 Normalized VGSt(h) vs. Junction Temperature**

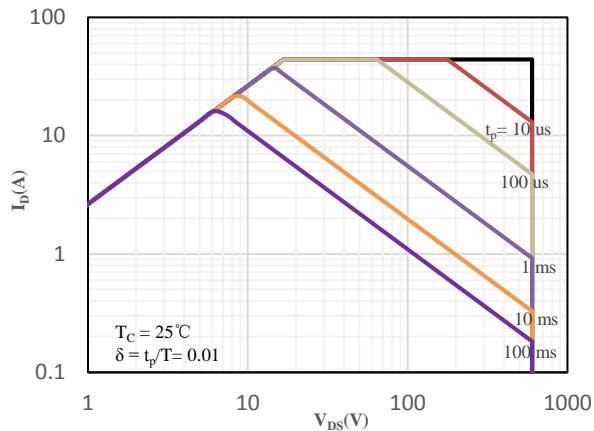


Fig 13 Safe Operating Area

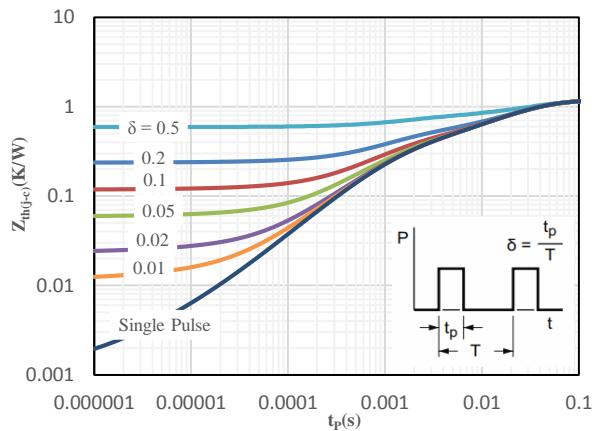
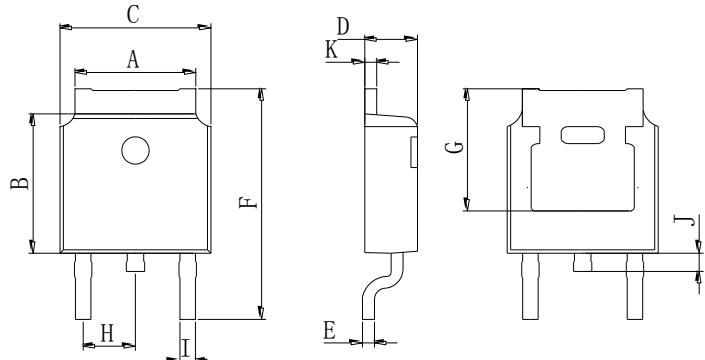


Fig 14 Maximum transient thermal impedance

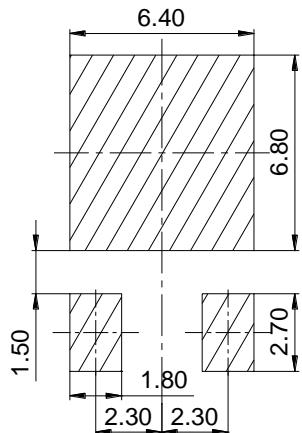
### Package Outline Dimensions (Unit: mm)



TO-252		
Dimension	Min.	Max.
A	5.05	5.65
B	5.80	6.40
C	6.25	6.85
D	2.20	2.40
E	0.40	0.60
F	9.71	10.31
G	5.05	5.65
H	2.10	2.50
I	0.70	0.90
J	0.50	0.70
K	0.40	0.60

### Mounting Pad Layout (Unit: mm)

TO-252



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